

Prüfbericht-Nr.: <i>Test report no.:</i>	IN22G8KZ 001	Auftrags-Nr.: <i>Order no.:</i>	146747176 0010	Seite 1 von 3 Page 1 of 3
Kunden-Referenz-Nr.: <i>Client reference no.:</i>	2288216	Auftragsdatum: <i>Order date:</i>	2022-12-19	
Auftraggeber: <i>Client:</i>	Zywie, Inc 12000 Findley Road, Suite 360, Johns Creek, GA-30097, USA			
Prüfgegenstand: <i>Test item:</i>	ZywieZ3™ Sensor & Adhesive			
Bezeichnung <i>Identification</i>	Z31000016	Serien -Nr.: <i>Serial no.:</i>	PRT0036	
Auftrags-Inhalt: <i>Order content:</i>	Testing and issue of Test Report with Grant Certificate			
Prüfgrundlage: <i>Test specification:</i>	FCC 1.1310			
Wareneingangsdatum: <i>Date of sample receipt:</i>	2022-12-20			
Prüfmuster-Nr.: <i>Test sample no:</i>	A003392716-001 & A003392716-002			
Prüfzeitraum: <i>Testing period:</i>	2022-12-20 - 2022-12-28			
Ort der Prüfung: <i>Place of testing:</i>	Wireless laboratory, Bangalore			
Prüflaboratorium: <i>Testing laboratory:</i>	TÜV Rheinland (India) Pvt. Ltd. 27/B, 2nd cross road, Electronic city Phase1, Bangalore-560100, India FCC Test Site Registration No: 496599 IC Test Site Registration No: 3466E-1			
Prüfergebnis*: <i>Test result*:</i>	Pass			
geprüft von: <i>tested by:</i>	genehmigt von: <i>authorized by:</i>			
Datum: <i>Date:</i>	2023-01-20	Ausstellatum: <i>Issue date:</i>	2023-04-06	
Stellung / Position:	M.V.Naveen Kumar Engineer	Stellung / Position:	Madhu K.N Senior Engineer	
Sonstiges / Other:	FCC ID: 2BAK3Z3E			
Zustand des Prüfgegenstandes bei Anlieferung: <i>Condition of the test item at delivery:</i>	Prüfmuster vollständig und unbeschädigt <i>Test item complete and undamaged</i>			
* Legende:	1 = sehr gut P(ass) = entspricht o.g. Prüfgrundlage(n)	2 = gut F(ail) = entspricht nicht o.g. Prüfgrundlage(n)	3 = befriedigend F(ail) = entspricht nicht o.g. Prüfgrundlage(n)	4 = ausreichend N/A = nicht anwendbar
* Legend:	1 = very good P(ass) = passed a.m. test specification(s)	2 = good F(ail) = failed a.m. test specification(s)	3 = satisfactory F(ail) = failed a.m. test specification(s)	4 = sufficient N/A = not applicable
Dieser Prüfbericht bezieht sich nur auf das o.g. Prüfmuster und darf ohne Genehmigung der Prüfstelle nicht auszugsweise vervielfältigt werden. Dieser Bericht berechtigt nicht zur Verwendung eines Prüfzeichens. <i>This test report only relates to the a. m. test sample. Without permission of the test center this test report is not permitted to be duplicated in extracts. This test report does not entitle to carry any test mark.</i>				

V05

RF Exposure Report

Following FCC KDB 447498 D01 General SAR test exclusion guidelines

The corresponding SAR exclusion threshold condition, listed below:

1) The 1-g and 10-g SAR test exclusion thresholds for 100 MHz to 6 GHz at test separation Distances ≤ 50 mm are determined by: $[(\text{max. power of channel, including tune-up tolerance, mW}) / (\text{min. test separation distance, mm})] \cdot [\sqrt{f} \text{ (GHz)}] \leq 3.0$ for 1-g SAR and ≤ 7.5 for 10-g.

Extremity SAR, where

- $f(\text{GHz})$ is the RF channel transmit frequency in GHz
- Power and distance are rounded to the nearest mW and mm before calculation.
- The result is rounded to one decimal place for comparison The test exclusions are applicable only when the minimum test separation distance is ≤ 50 mm and for transmission frequencies between 100 MHz and 6 GHz. When the minimum test separation distance is < 5 mm, a distance of 5 mm according to 5) in section 4.1 is applied to determine SAR test exclusion(447498 D01 General RF Exposure Guidance v06)

2) At 100 MHz to 6 GHz and for test separation distances > 50 mm, the SAR test exclusion threshold is determined according to the following

- $[\text{Power allowed at numeric threshold for 50 mm in step 1}) + (\text{test separation distance} - 50 \text{ mm}) \cdot (f(\text{MHz})/150)] \text{ mW}$, at 100 MHz to 1500 MHz
- $[\text{Power allowed at numeric threshold for 50 mm in step 1}) + (\text{test separation distance} - 50 \text{ mm}) \cdot 10] \text{ mW}$ at > 1500 MHz and ≤ 6 GHz

3) At frequencies below 100 MHz, the following may be considered for SAR test exclusion,

- The power threshold at the corresponding test separation distance at 100 MHz in step 2) is multiplied by $[1 + \log(100/f(\text{MHz}))]$ for *test separation distances* > 50 mm and < 200 mm
- The power threshold determined by the equation in a) for 50 mm and 100 MHz is multiplied by $\frac{1}{2}$ for *test separation distances* ≤ 50 mm
- SAR measurement procedures are not established below 100 MHz When SAR test exclusion cannot be applied, a KDB inquiry is required to determine SAR evaluation requirements for any test results to be acceptable.

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SAR Test Exclusion Thresholds

Maximum Measured Transmitter Power:

Frequency (GHz)	Max.Power Including Tune-up Tolarence (dBm)	Max.Power Including Tune-up Tolarence (mW)	Min.Test Separation distance (mm)	SAR Test Exclusion Calculation Values	1-g Extremity SAR Test exclusion Thresholds
2.402	4.72	2.9648	1.19	0.9189	≤3
2.426	4.36	2.7289	1.19	0.8500	≤3
2.480	3.77	2.3823	1.19	0.7503	≤3

Hence, the EUT is exempted from routine SAR evaluation

Note:

1. Calculate SAR exclusion threshold from condition 1) formulas.
2. Client declared as tune up tolerance 0dB